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Application/Control No.	Applicant(s)/Patent under Reexamination
10/791,217	GOULMY ET AL.
Examiner	Art Unit
Phuong Huynh	1644

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Class	Subclass	Date	Examiner
435	325	8/16/2005	PNH
424	184.1, 18	8/16/2005	PNH
530	328	8/16/2005	PNH

INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
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